

<b>Notice of References Cited</b>	Application/Control No. 10/574,038		Applicant(s)/Patent Under Reexamination HOSAKA ET AL.	
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*	A	US-6,103,413	08-2000	Hinton et al.	429/32
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	K	US-			
	L	US-			
	M	US-			

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#### NON-PATENT DOCUMENTS

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